

Notice of References Cited

Application/Control No.

10/536,570

Applicant(s)/Patent Under
Reexamination
BULTHUIS ET AL.

Examiner

Daniel J. Petkovsek

Art Unit

2874

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,922,510	07-2005	Hatanaka, Takaaki	385/50
*	B	US-6,631,223	10-2003	Arai et al.	385/24
*	C	US-6,084,992	07-2000	Weber et al.	385/24
*	D	US-2004/0234199	11-2004	Melloni et al.	385/032
*	E	US-2003/0165295	09-2003	Doerr, Christopher	385/39
*	F	US-2003/0039461	02-2003	How Kee Chun et al.	385/140
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

DJP 12/13/07